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PATENT AND TRADEMARK OFFICE

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FOTLAND ET AL FILING DATE

APPLICANT

April 27, 1999

GROUP 1734

09/299,388

U.S. PATENT DOCUMENTS

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			5	4	9	0	9	6	2	2/13/96	Cima et al	264	22	
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FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

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OTHER DOCUMENTS (Including Author, Title, Date**, Relevant Pages, Place of Publication***)

20	Science News, Vol. 151, page 205, "Ink jets not just for the printed page". (April 5, 1997)
	princed page . (April 3, 1997)
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